

A combined continuous-wave and pulsed microwave copper chloride discharge

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Pulsed and continuous-wave microwaves at 2.45 GHz combined in an Asmussen resonant cavity are used to vaporize, dissociate, and excite copper chloride discharges. Steady state microwaves from 50 to 150 W sustain a microwave discharge which heats and dissociates the copper chloride to a sufficient vapor pressure. A variable frequency (2.45 to 2.60 GHz) pulsed microwave source with pulse widths ranging from 0.5 to 2 ms, repetition rates of 500 to 5000 Hz and a peak output power of 4,500 W then excites the copper atomic states. The two microwave signals are superimposed using a hybrid junction before input into the resonant cavity. Microwave frequencies of the pulsed portion of the signal around 2.50 GHz provided maximum absorption by the discharge. This device is being examined as a potential pump source for a copper vapor laser.

I. INTRODUCTION

Microwave discharges have been shown to be an effective pump source for excimer¹⁻⁵ and HeNe lasers.⁶ The benefits of microwave discharges are the absence of electrodes, high coupling efficiency of microwave power to the laser medium, the relatively low cost of microwave components, the high repetition rates needed for pulsed laser sources are within the range of microwave sources, and the ability of microwaves to penetrate deeply into a plasma which allows for large diameters and uniform laser beam profiles.⁷

Current copper vapor lasers^{8,9} (510.6 and 578.2 nm) and copper chloride lasers¹⁰⁻¹⁴ use repetitively pulsed electrical discharges between two electrodes to excite a copper vapor. In these systems the electrical discharges also vaporize the copper chloride. This paper presents a new method of heating and exciting copper chloride using microwaves, along with a method for combining a pulsed and continuous-wave (cw) microwave signal in a resonant cavity for laser applications.

II. EXPERIMENT

Copper chloride/helium discharges are excited in the transverse-magnetic (TM₀₁₂) mode of an Asmussen resonant cavity.¹⁵⁻¹⁷ The brass resonant cavity has an adjustable length of 6 to 16 cm which allows for various operating modes and also for shifts in the resonant frequency caused by the discharge. An adjustable coupling probe located in the wall of the cavity excites the standing waves inside the cavity and acts as a variable impedance transformer. A wire mesh window opposite of the coupling probe provides visible access to the plasma discharge, and holes in the cavity wall placed along the axis of the cavity provides for the insertion of diagnostic probes.

The cw microwave source is a Micro-Now magnetron oscillator which operates at 2.45 GHz with continuously

adjustable power ranging from about 50 to 500 W. An (EPSCO) high power pulsed signal source operating from 2.35 to 2.7 GHz provides pulsed microwave signals with pulse widths ranging from 0.5 to 2 μ s, at repetition rates ranging from 500 to 5000 pulses per second for a peak output power of 4500 W. A schematic of the microwave circuit is shown in Fig. 1. Terminated three port circulators protect the two power supplies. A hybrid junction adds the two microwave signals together and dual-directional couplers are used to monitor the power. Coaxial cables with Type N connections transmit the microwave signals. The cw power is measured with thermistor sensors monitored by analog power meters. The combined cw and pulsed signals are measured using crystal diode detectors. A typical power trace is shown in Fig. 2. The total power absorbed by the discharge is taken to be the difference between the measured incident and reflected power. Note that one major disadvantage of this system is that the hybrid junction splits each signal in half. Thus 50% of both signals is currently disregarded. However, an advantage to this system is that the power levels, pulse width, pulse repetition, and pulse frequency are fully adjustable to suit the plasma conditions.

Typical absorbed powers and operating parameters are shown in Table I. The electron densities, collisional frequencies, and cavity electric and magnetic fields are estimated using an electromagnetic model developed earlier.^{17,18} Figure 3 shows the electric field configuration in the cavity for the TM₀₁₂ mode as calculated from the model, along with the typical plasma position.

The plasma is contained within a 25 mm inside diameter (i.d.) [28 mm outside diameter (o.d.)] quartz tube located along the axis of the resonant cavity. Helium is used as the buffer gas. (QF) 25 fittings are attached to each end of the tube. A "tee" made up of three QF fittings is attached to each end of the tube, as shown in Fig. 4. Gas is supplied to one tee and a vacuum system is attached to the other tee. Two Lucite windows, or Brewster's windows, attached to the tee ends allows for viewing the plasma along the axis of the tube.

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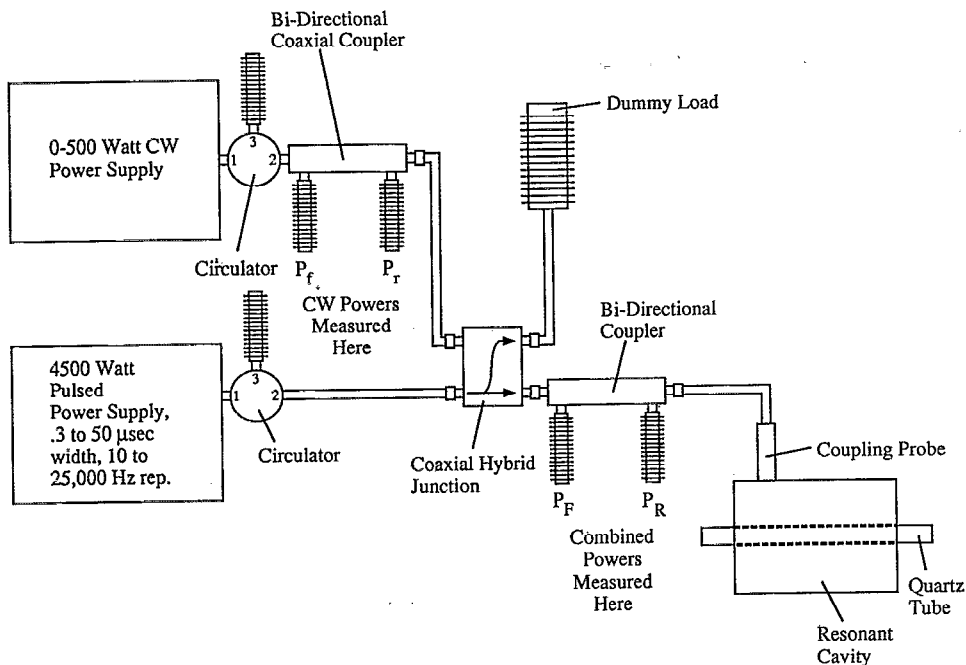


FIG. 1. The microwave circuit used to superimpose the continuous wave and pulsed microwave power sources. One disadvantage to this system is that half of the total power is disregarded.

Cupric chloride (CuCl_2) with a melting temperature of 695 K is used as the copper source. Two methods are used to obtain a copper chloride vapor. The first uses a resistive tape to heat a reservoir of copper chloride crystals upstream of the resonant cavity. This method is difficult to implement because the copper vapor recombines on the walls of the discharge tube before reaching the discharge region.

In the second method, a small amount of copper chloride powder is placed directly inside the quartz tube in the center of the discharge region of the cavity. A cw microwave signal at 2.45 GHz and about 70 W absorbed power heats the helium buffer gas to temperatures of 800 K and higher. The helium collisionally transfers the thermal energy to the copper chloride which is then vaporized and

dissociated. Temperature gradients across the quartz tube wall often cause the copper chloride discharge to become unstable. To overcome this, glass wool (quartz) was wrapped around the tube to provide insulation. The addition of the glass wool greatly increases the stability of the discharge. A disadvantage to this is that the glass wool reduces the quality or Q factor of the cavity.

The copper vapor density is approximated by an estimate of the temperature of the discharge and the vapor pressure of the copper chloride, which is a function of temperature as given in Ref. 19. It is assumed that the cw portion of the microwave signal provides the majority of the heating. A simple energy conservation equation can be written as:²⁰

$$\nabla \cdot (\kappa \nabla T) + P_d = 0, \quad (1)$$

where T is the discharge neutral gas temperature, κ is the thermal conductivity and P_d is the dissipated power. We also assume that helium constitutes most of the discharge, or that the copper chloride content is negligible compared to the helium content. The thermal conductivity for helium is found in Ref. 21 and is fit to $\kappa = aT^{1/2} + b$, a typical

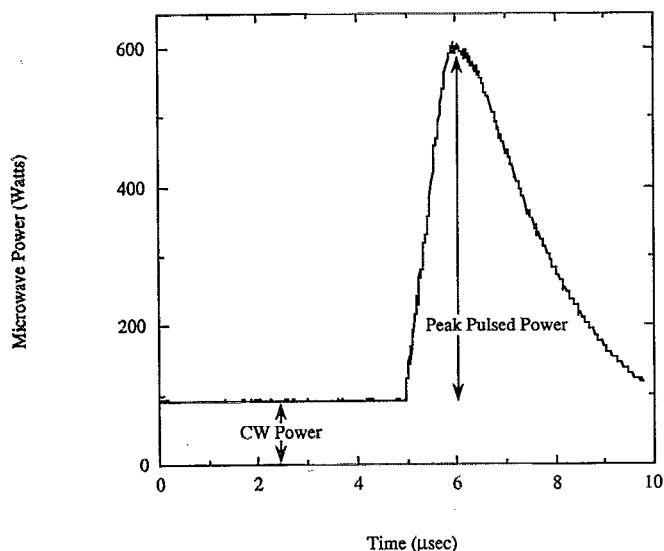


FIG. 2. A typical power trace of the combined microwave signal showing the cw and pulsed microwaves.

TABLE I. Typical operating parameters of the copper chloride microwave discharges.

| | |
|-------------------------|---|
| Resonant frequency | 2.45 GHz |
| cw power | 50 to 150 W |
| Peak pulsed power | 80 to 510 W |
| Pulse width | 0.5 to 2 μs |
| Pulse frequency | 2.45 to 2.6 GHz |
| Pulse repetition | 500 to 5000 Hz |
| Buffer gas | Helium |
| Buffer pressure | 2 to 100 Torr |
| Neutral gas temperature | 750 to 820 K |
| Electron density | 10^{11} to 10^{12} cm^{-3} |
| Collision frequency | 10^{10} to 10^{12} s^{-1} |

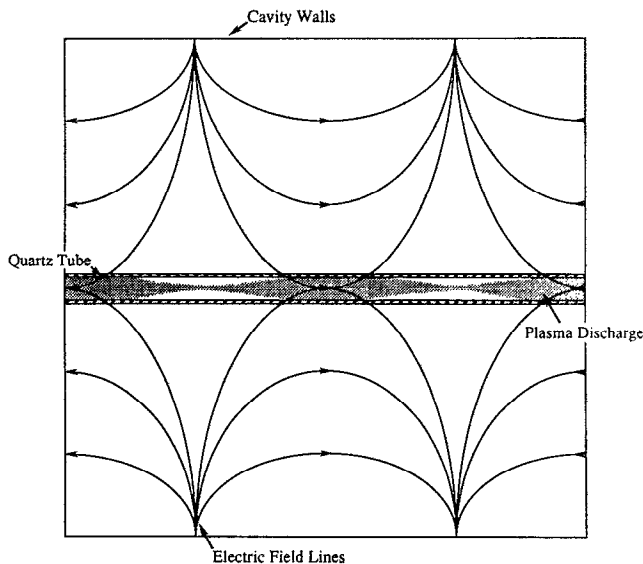


FIG. 3. The electric field lines of a TM_{012} standing wave. The shaded area shows the position of the plasma discharge.

form for atomic gases.²² Assuming that $P_d(r)$ varies as the ratio of the plasma volume at a radius r to the total plasma volume, i.e., $P_d(r) = (r^2/a^2) P_p$ where a is the radius of the containment tube and P_p is the total power absorbed by the plasma, Eq. (1) can be solved for the temperature as a position of radius. An average temperature is defined as the average of the temperature at the wall and at the center of the quartz tube. The wall temperature is assumed to be at most 695 K, the melting point of copper chloride. The estimated gas temperatures were around 780 K for all pressures (2 to 100 Torr) and powers (50 to 100 W) studied. This temperature corresponds to a copper vapor pressure of about 1.7 Torr.¹⁹

The major diagnostic of the copper chloride/helium plasma is optical emission spectroscopy. Light is collected from the end window (along the axis) of the discharge and is imaged onto the entrance slit of a one meter spectrograph coupled to a 1024 channel intensified diode array. The detector is gated by a pulse driver which is triggered by a pulse generator, which also triggers the pulsed microwave supply. By introducing a delay between the power supply trigger and the detector gate pulse, time resolved spectra could be recorded. The width of the detector gate was usually 100 ns.

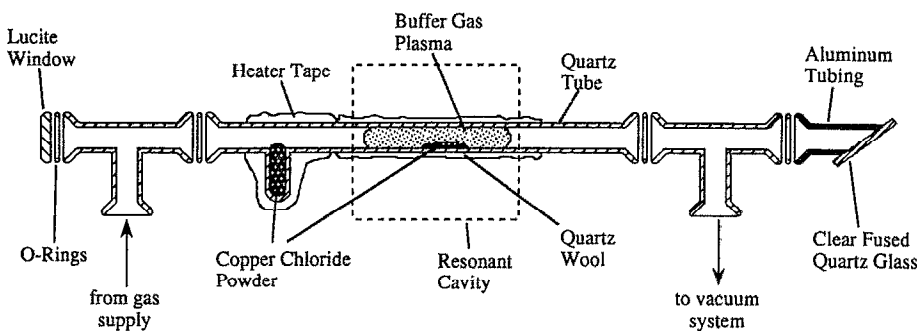


FIG. 4. The quartz tube used to house the plasma discharge. Glass wool was used to insulate the tube to provide high temperatures needed to melt copper chloride.

III. RESULTS

The optical emission of the copper chloride/helium plasmas was monitored for a variety of conditions. The laser states (510.6 and 578.2 nm) were monitored along with nonlasing states. Figure 5(b) shows a spectra obtained during the cw portion of the microwave signal. As shown in Fig. 5(a), the lasing transition at 510.6 nm was greatly enhanced during the pulsed and cw portion of the microwave signal. Figures 6 and 7 show similar results for the 324.8 and 327.4 nm pumping transitions and the 578.2 nm lasing transition, respectively. Obviously, such enhancement of the emissions shows great promise for laser operation. If high enough power densities are obtained, repetitively pulsed laser action should be possible.

The intensity of the copper 510.6 nm line and the corresponding microwave power is shown in Fig. 8. Note that the peak in this emission occurs during the peak of the microwave power. Similar results were observed for the copper 324.8, 327.4, and 578.2 nm lines, as well as the helium emission lines.

Adjustment of the frequency of the pulsed microwave signal was necessary to achieve maximum power absorption by the plasma. The value of the pulsed microwave frequency was usually around 2.50 GHz, but always greater than 2.45 GHz. This upshift in the resonant frequency agrees with what is expected from theory, as shown by Buchsbaum *et al.*,²³ who gives the frequency shift as:

$$\frac{\Delta\omega}{\omega_0} \approx \frac{1}{2} \frac{\int [(\eta/(1+\gamma^2))] E_0^2 dV}{\int E_0^2 dV}, \quad (2)$$

where E_0 is the electric field of an unloaded cavity, ω_0 is the resonant frequency of the cavity, $\eta = n_e e^2 / m_e \epsilon_0 \omega_0^2$, n_e is the electron density, and γ is the collisional frequency normalized to the resonant frequency i.e., ν/ω_0 . Persson²⁴ showed that this technique could be used up to plasma densities of 10^{12} $1/\text{cm}^3$ if the electric fields are perpendicular to any density gradients. As an approximation, we assume that the fields of the TM_{012} mode satisfy this requirement. This is a justified because the gradients are in the radial direction and the radius of the plasma is small compared to the radius of the cavity. It is also assumed that the plasma consists entirely of the helium buffer, so that the collision frequency can be calculated from²⁵

$$(\nu_c)_{He} = 2.37 \times 10^9 p_0, \quad (3)$$

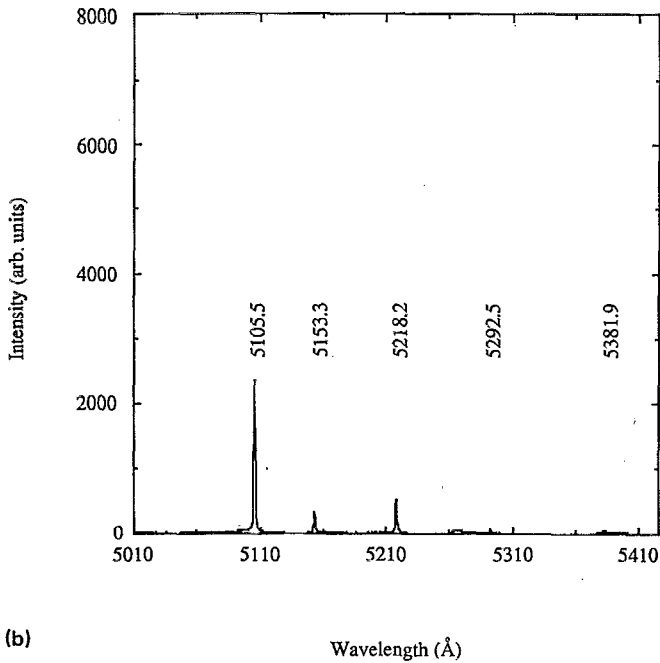
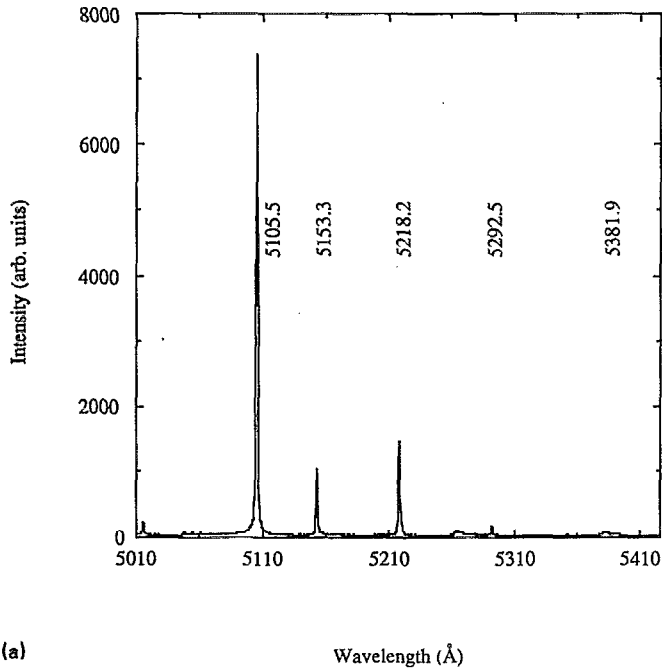


FIG. 5. (a) Emission spectra (501.0 to 541.0 nm) during the microwave pulse with an absorbed cw power of 101 W, an absorbed pulsed power of 90 W, a pulse width of 1 μ s, at a pressure of 2 Torr, and a repetition rate of 500 Hz. (b). Emission spectra (501.0 to 541.0 nm) during the cw portion of the microwave signal for the conditions of Fig. 5(b).

$$p_0 = p_m \frac{273 \text{ K}}{T_g}, \quad (4)$$

where p_0 is the reduced pressure, p_m is the measured buffer gas pressure, and T_g is the gas temperature estimated using Eq. (1). Plugging in the electric fields for the TM_{012} mode allows for the calculation of the electron density. Results of this technique predict electron densities of around

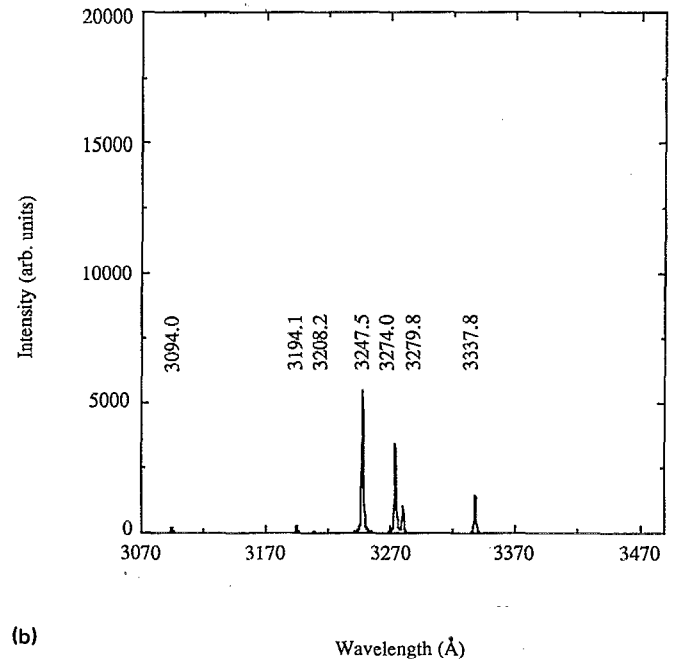
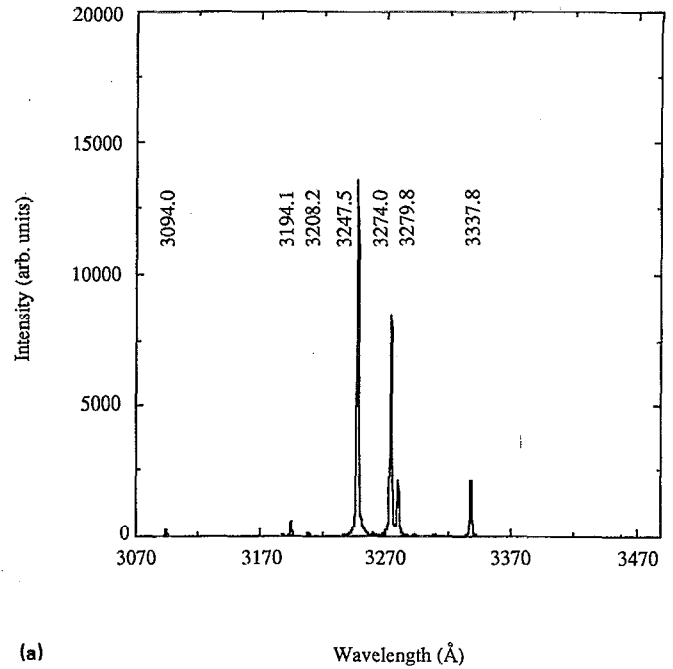
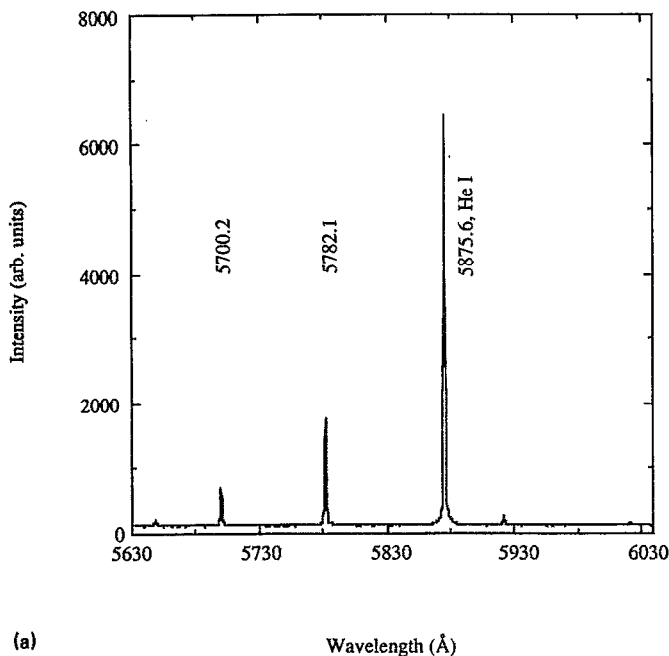


FIG. 6. (a) Emission spectra (307.0 to 347.0 nm) during the microwave pulse with an absorbed cw power of 101 W, an absorbed pulsed power of 250 W, a pulse width of 1 μ s, at a pressure of 2 Torr, and a repetition rate of 500 Hz. (b) Emission spectra (307.0 to 347.0 nm) during the cw portion of the microwave signal for the conditions of Fig. 6(b).

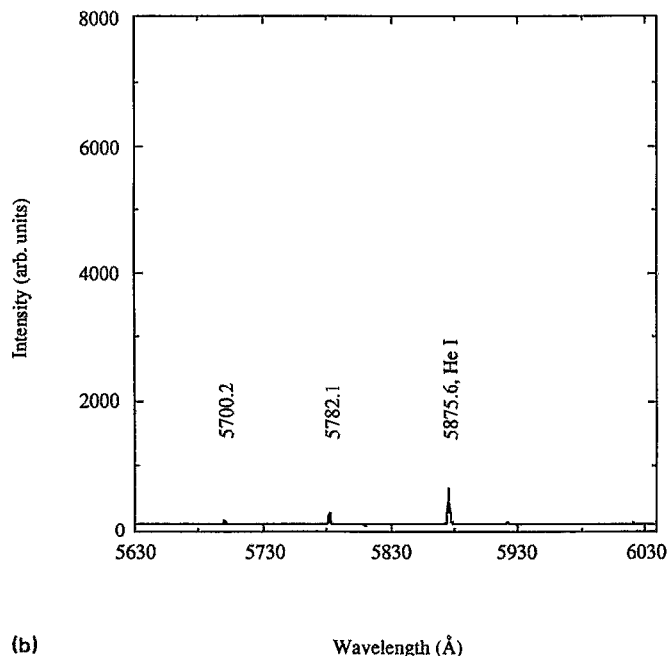
$2 \times 10^{11} \text{ 1/cm}^3$, which agrees with the results of the electromagnetic model mentioned earlier.

IV. DISCUSSION

Results show that the mixing of cw and pulsed microwaves at 2.45 GHz is easily accomplished, although power losses encountered are high (at least 50%). The mixing of the two signals is accomplished using a hybrid junction.



(a)



(b)

FIG. 7. (a) Emission spectra (563.0 to 603.0 nm) during the microwave pulse with an absorbed cw power of 93 W, an absorbed pulsed power of 390 W, a pulse width of 1.5 μ s, at a pressure of 2 Torr, and a repetition rate of 1,000 Hz. (b) Emission spectra (563.0 to 603.0 nm) during the cw portion of the microwave signal for the conditions of Fig. 7(b).

The combined signal is then used to initiate a plasma discharge in an Asmussen resonant cavity.

Optical spectroscopy is used as a diagnostic to observe the effects of the pulsed microwaves on the plasma. Time resolved spectroscopy indicates that the light emission follows the microwave power, which shows that the pulsed microwaves have a definite effect on the plasma discharge. Enhancement of the intensity of emissions is also shown to be due to the pulsed portion of the microwave signal.

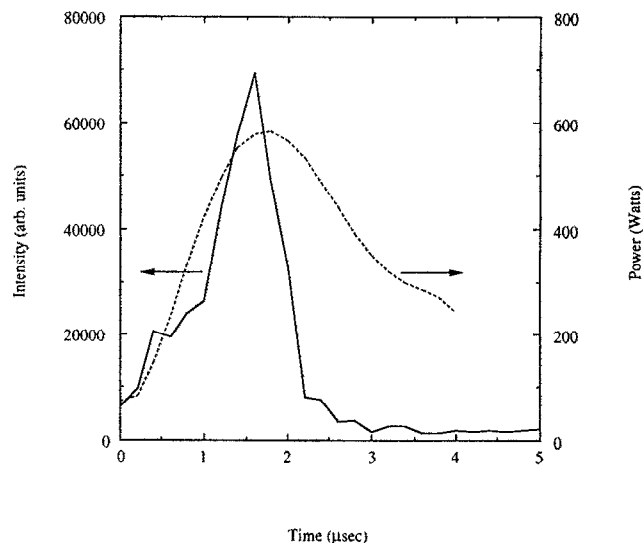


FIG. 8. A time resolved spectra showing the emission of the copper 510.6 nm transition, along with the microwave power trace. The absorbed power was 74 W with a peak pulsed power of 510 W, a pulse width of 2 μ s, a pressure of 2.5 Torr, and a repetition rate of 1,000 Hz.

Shifts in the resonant frequency of the cavity are also used as diagnostics of the plasma discharge. The shifts are due to the presence of the plasma and a model is used to determine the electron density of the discharges. Results of the model predict electron densities around 2×10^{11} $1/\text{cm}^3$.

This concept is presently being applied to a copper chloride discharge in hopes of producing a microwave pumped repetitively pulsed copper vapor laser. Results show that the copper chloride is dissociated by the cw microwaves, and copper transitions of laser states are increased by the pulsed microwaves.

ACKNOWLEDGMENT

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